

Notice of References Cited

Application/Control No.

10/591,524

Applicant(s)/Patent Under
Reexamination
TASHIRO ET AL.

Examiner

Liam J. Heincer

Art Unit

1796

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,455,265 A	06-1984	Haldeman, Janice L.	524/145
*	B	US-4,549,897 A	10-1985	Seng et al.	504/101
*	C	US-5,321,111 A	06-1994	Ji, Wan	528/1
*	D	US-5,569,740 A	10-1996	Tanaka et al.	528/502F
*	E	US-5,563,241 A	10-1996	Beezhold, Donald H.	528/482
*	F	US-5,585,459 A	12-1996	Tanaka et al.	528/486
*	G	US-5,741,885 A	04-1998	Dove, Jeffrey S.	604/349
*	H	US-5,777,004 A	07-1998	Trautman, Jack C.	523/310
*	I	US-5,908,893 A	06-1999	Kawasaki et al.	524/575.5
*	J	US-5,910,567 A	06-1999	Tanaka et al.	528/491
*	K	US-5,998,512 A	12-1999	Schloman, William W.	524/17
*	L	US-6,054,525 A	04-2000	Schloman et al.	524/575.5
*	M	US-6,235,860 B1	05-2001	Kang et al.	528/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Machine Translation of JP 2004-099696 A				
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,265,479 B1	07-2001	Ichikawa et al.	524/575.5
*	B	US-6,306,955 B1	10-2001	Kawasaki et al.	524/575.5
*	C	US-6,462,159 B1	10-2002	Hamada et al.	526/336
*	D	US-6,518,355 B1	02-2003	Shibata et al.	524/575.5
*	E	US-2003/0040599 A1	02-2003	Mukherjee et al.	528/480
*	F	US-2003/0088006 A1	05-2003	Yanagisawa et al.	524/425
*	G	US-2004/0014876 A1	01-2004	Ichikawa et al.	524/575.5
*	H	US-2004/0031086 A1	02-2004	Huynh et al.	2/161.7
*	I	US-2004/0106724 A1	06-2004	Toratani et al.	524/575
*	J	US-7,015,264 B2	03-2006	Ichikawa et al.	524/17
*	K	US-2006/0252879 A1	11-2006	Tanaka et al.	524/571
*	L	US-2007/0265408 A1	11-2007	Cornish et al.	528/001
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
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